

### IGBT<sup>3</sup> Chip

#### **FEATURES:**

- 1200V Trench + Field Stop technology
- 120µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

#### This chip is used for:

power module



#### Applications:

drives

Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code	
SIGC32T120R3L	1200V	25A	6.5 x 4.87 mm <sup>2</sup>	sawn on foil	Q67050- A4206-A101	

#### **MECHANICAL PARAMETER:**

Raster size	6.5 x 4.87			
Emitter pad size ( include gate pad )	3.4 x 4.99			
Gate pad size	1.14 x 1.14			
Area total / active	31.6 / 21.5	mm <sup>2</sup>		
Thickness	120	μm		
Wafer size	150	mm		
Flat position	180	grd		
Max.possible chips per wafer	454 pcs			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm AlSiCu			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	AI, <500μm			
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



#### MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T <sub>j</sub> =25 °C	V <sub>CE</sub>	1200	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	А
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	75	Α
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55 <b>+</b> 150	°C

<sup>1)</sup> depending on thermal properties of assembly

#### STATIC CHARACTERISTICS (tested on chip), $T_i$ =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
- urumeter	- Containing		min.	typ.	max.	O.I.I.
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0 $V$ , $I_{C}$ = 1 $mA$	1200			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =25A	1.35	1.65	2.05	V
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	I <sub>C</sub> =1mA , V <sub>GE</sub> =V <sub>CE</sub>	5.0	5.8	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1200V , V <sub>GE</sub> =0V			3.35	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V , V <sub>GE</sub> =20V			600	nA
Integrated gate resistor	R <sub>Gint</sub>			8		Ω

#### **ELECTRICAL CHARACTERISTICS** (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiailletei	Symbol	Conditions	min.	typ.	max.	Onne
Input capacitance	Ciss	V <sub>CE</sub> =25V,		1808		pF
Output capacitance	Coss	$V_{GE}=0V$ ,		95		
Reverse transfer capacitance	Crss	f=1MHz		82		

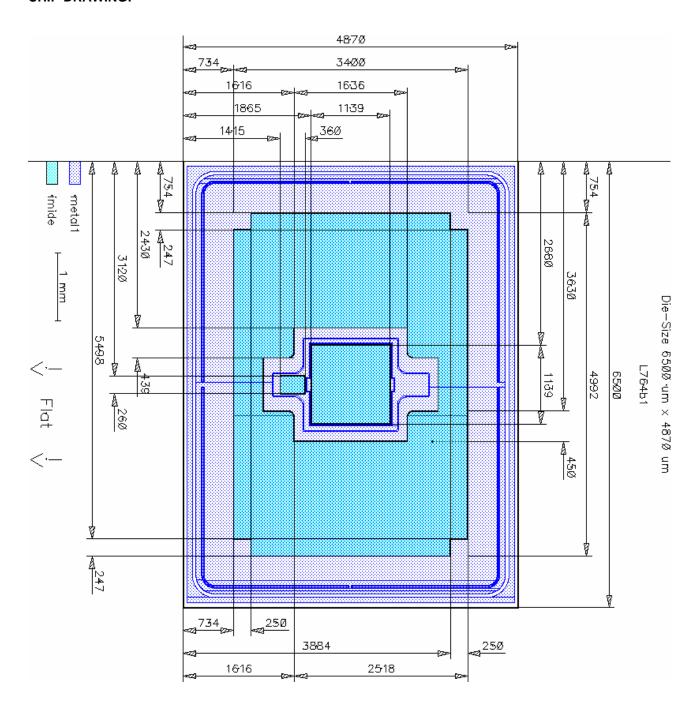
#### SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions 1)	Value			Unit
	Symbol		min.	typ.	max.	Oilit
Turn-on delay time	$t_{d(on)}$	<i>T</i> <sub>j</sub> =125°C		0.09		μs
Rise time	t <sub>r</sub>	$V_{\rm CC} = 600  \text{V},$		0.05		
Turn-off delay time	$t_{d(off)}$	I <sub>C</sub> =25A, V <sub>GE</sub> =-15/15V,		0.52		
Fall time	t <sub>f</sub>	$R_{\rm G}$ = 36 $\Omega$		0.09		

 $<sup>^{1)}</sup>$  values also influenced by parasitic L- and C- in measurement and package.



#### **CHIP DRAWING:**





#### **FURTHER ELECTRICAL CHARACTERISTICS:**

This chip data sheet refers to the device data sheet	tbd	
DESCRIPTION:		
AQL 0,65 for visual inspection according to fai	lure catalog	
Electrostatic Discharge Sensitive Device acco	rding to MIL-STD 883	
Test-Normen Villach/Prüffeld		

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